Application/Control No. Applicant(s)/Patent Under Reexamination BALECH, JEAN-PIERRE Examiner Khanh Tran Applicant(s)/Patent Under Reexamination BALECH, JEAN-PIERRE Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,983,101	11-1999	Billstrom, Jan-Olof	455/452.2
	В	US-6,289,217	09-2001	Hamalainen et al.	455/425
	С	US-5,740,208	04-1998	Hulbert et al.	375/346
	D	US-6,212,240	04-2001	Scheibel et al.	375/261
	Е	US-6,442,146	08-2002	Onodera et al.	370/321
	F	US-6,452,964	09-2002	Yoshida, Makoto	375/222
	G	US-			
	Н	US-			
	ı	US-		•	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q	·				
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	J							
	>							
	8							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.